SPECIFICATIONS

Customer								
Product Name		Multi-layer Chip Ferrite Bead						
Sunlord Part No	umber			5	SZ-C Serie	es		
Customer Part	Number							
	. —						0=0406	
⊠New Release	<i>'</i> —	-					SZ0402	221000
This SPEC is total	. •		•		nd appendi	x.]		
ROHS, Halogen-F	ree and SV	HC Con	npliant	Parts]				
	Approve	d By	Che	cked By	Issued	l By		
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Shenzhe					, Baoan, Sh	nenzhen	, China	518 ²
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[Version change history]

Rev.	Effective Date	Changed Contents	Change reasons	Approved By
01	/	New release	/	Hai Guo

Caution

All products listed in this specification are developed, designed and intended for use in general electronics equipment. The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require especially high reliability, or whose failure, malfunction or trouble might directly cause damage to society, person, or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below. Please contact us for more details if you intend to use our products in the following applications.

- 1. Aircraft equipment
- 2. Aerospace equipment
- 3. Undersea equipment
- 4. nuclear control equipment
- 5. military equipment
- 6. Power plant equipment
- 7. Medical equipment
- 8. Transportation equipment (automobiles, trains, ships, etc.)
- 9. Traffic signal equipment
- 10. Disaster prevention / crime prevention equipment
- 11. Data-processing equipment
- 12. Applications of similar complexity or with reliability requirements comparable to the applications listed in the above

1. Scope

This specification applies to SZ-C series of multi-layer ferrite chip beads.

2. Product Description and Identification (Part Number)

1) Description:

SZ-C series of Multi-layer ferrite chip beads.

2) Product Identification (Part Number)

<u>SZ</u>	<u>****</u>	<u>O</u>	XXX	С	0	<u>F</u>
1	2	3	4	(5)	6	7

1	① Type			
	SZ	For High Speed Signal		

3	Material Code	
	G, K	

(5)	Inner Code			
Feature Code				

7	HSF Products
На	zardous Substance Free Products

2	External Dimens	ions (L X W)[mm]
	1005 [0402]	1. 0X 0.5
1608 [0603]		1.6 X 0.8

4 Nominal	Nominal Impedance		
Example	Nominal Value		
600	60Ω		
121	120Ω		

6		Packing	
	Т		Tape Carrier Package

3. Electrical Characteristics

Please refer to Appendix A (Page 8~9).

- 1) Operating and storage temperature range (individual chip without packing): -55°C ~+125°C.
- 2) Storage temperature range (packaging conditions): -10 $^{\circ}$ C ~+40 $^{\circ}$ C and RH 70% (Max.).

4. Shape and Dimensions

- 1) Dimensions and recommended PCB pattern for reflow soldering: See Fig.4-1, Fig.4-2 and Table 4-1.
- 2) Structure: See Fig. 4-3 and Fig. 4-4.

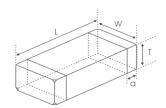
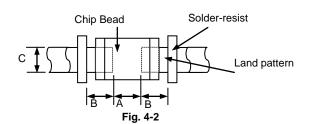
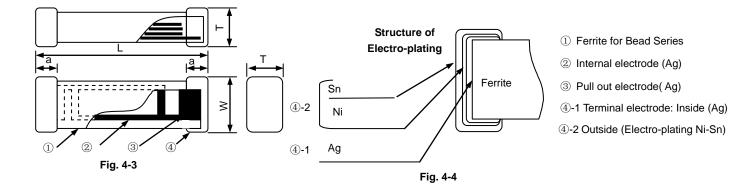


Fig. 4-1



[Table 4-1] Unit: mm [inch]

Type	L	W	Т	а	Α	В	С
1005	1.0±0.15	0.5±0.15	0.5±0.15	0.25±0.1	0.45.055	0.40, 0.50	0.45.055
[0402]	[0.039±0.006]	[0.020±0.006]	[0.020±0.006]	[0.010±0.004]	0.45~0.55	0.40~0.50	0.45~0.55
1608	1.6±0.15	0.8±0.15	0.8±0.15	0.3±0.2	0.60.000	0.60~0.80	0.60 0.80
[0603]	[0.063±0.006]	[0.031±0.006]	[0.031±0.006]	[0.012±0.008]	0.60~0.80	0.60~0.80	0.60~0.80



Material information: See Table 4-2.

[Table 4-2]

Code	Part Name	Material Name	
1	Ferrite Body	Ferrite Powder	
2	Inner Coils	Silver Paste	
3	Pull-out Electrode (Ag)	Silver Paste	
4 -1	Terminal Electrode: Inside Ag	Termination Silver Composition	
4 -2	Electro-Plating: Ni/Sn plating	Plating Chemicals	

5. Test and Measurement Procedures

5.1 Test Conditions

Unless otherwise specified, the standard atmospheric conditions for measurement/test as:

a. Ambient Temperature: 20±15°Cb. Relative Humidity: 65±20%

c. Air Pressure: 86kPa to 106kPa

If any doubt on the results, measurements/tests should be made within the following limits:

a. Ambient Temperature: 20±2°C

b. Relative Humidity: 65±5%

c. Air Pressure: 86kPa to 106kPa

5.2 Visual Examination

a. Inspection Equipment: 20x magnifier

5.3 Electrical Test

5.3.1 DC Resistance (DCR)

- a. Refer to Appendix A.
- b. Test equipment (Analyzer): High Accuracy Milliohmmeter-HP4338B or equivalent.

5.3.2 Impedance (Z)

- a. Refer to Appendix A.
- b. Test equipment: High Accuracy RF Impedance/Material Analyzer-E4991A or equivalent.

Test fixture: HP16192A Test signal: -20dBm or 50mV.

c. Test frequency refers to Appendix A.

5.3.3 Rated Current

- a. Refer to Appendix A.
- b. Test equipment (see Fig. 5.3.3-1): Electric Power, Electric current meter, Thermometer.
- c. Measurement method (see Fig. 5.3.3-1):
 - 1. Set test current to be 0mA.
 - 2. Measure initial temperature of chip surface.
 - 3. Gradually increase voltage and measure chip temperature for corresponding current.
- d. Definition of Rated Current(Ir): Ir is direct electric current as chip surface temperature rose just 20[°]C against chip initial surface temperature(Ta) (see Fig. 5.3.3-2).

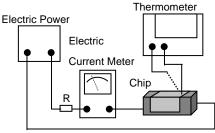


Fig. 5.3.3-1

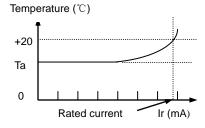


Fig. 5.3.3-2

5.4 Reliability Test

Items	Requirements	Test Methods and Remarks			
5.4.1 Terminal Strength	No removal or split of the termination or other defects shall occur. Chip Mounting Pad Glass Epoxy Board Fig.5.4.1-1	 Solder the bead to the testing jig (glass epoxy board shown in Fig. 5.4.1-1) using leadfree solder. Then apply a force in the direction of the arrow. 5N force for 1005 and 1608 series Keep time: 10±1s Speed: 1.0mm/s 			
5.4.2 Resistance to Flexure	Unit: mm [inch] Type a b c 1005[0402] 0.4 1.5 0.5 1608[0603] 1.0 3.0 1.2 Description of the property of the	Solder the bead to the test jig (glass epoxy board shown in Fig. 5.4.2-1) Using a leadfree solder. Then apply a force in the direction shown Fig. 5.4.2-2. Flexure: 2mm Pressurizing Speed: 0.5mm/sec. Keep time: 30 sec. R230 Flexure Flexure Flexure Fig. 5.4.2-2			
5.4.3 Vibration	No visible mechanical damage. Impedance change: within ±20% Cu pad Solder mask Glass Epoxy Board Fig. 5.4.3-1	 Solder the bead to the testing jig (glass epoxy board shown in Fig. 5.4.3-1) using leadfree solder. The bead shall be subjected to a simple harmonic motion having total amplitude of 1.5 mm, the frequency being varied uniformly between the approximate limits of 10 and 55 Hz. The frequency range from 10 to 55 Hz and return to 10 Hz shall be traversed in approximately 1 minute. This motion shall be applied for a period of 2 hours in each 3mutually perpendicular directions (total of 6 hours). 			
5.4.4 Dropping	No visible mechanical damage. Impedance change: within ±20%	Drop chip bead 10 times on a concrete floor from a height of 100 cm.			
5.4.5 Temperature 5.4.6 Solderability	Impedance change should be within ±20% of initial value measuring at 20°C. 1 No visible mechanical damage. 2 Wetting shall exceed 95%.	Temperature range: -55°C ~ 125°C. Reference temperature: +20°C. ① Solder temperature: 240±2°C ② Duration: 3 sec. ③ Solder: Sn/3.0Ag/0.5Cu. ④ Flux: 25% Resin and 75% ethanol in weight.			
5.4.7 Resistance to Soldering Heat	 No visible mechanical damage. Wetting shall exceed 95% Impedance change: within ±20%. 	 Solder temperature: 260±3°C Duration: 5 sec. Solder: Sn/3.0Ag/0.5Cu. Flux: 25% Resin and 75% ethanol in weight. The chip shall be stabilized at normal condition for 1~2 hours before measuring. 			
5.4.8 Thermal Shock	① No mechanical damage. ② Impedance change: Within ±20%. 125℃ Ambient Temperature -55℃ Fig. 5.4.8-1 20sec. (max.)	 Temperature, Time: (See Fig. 5.4.8-1) -55 °C for 30±3 min→125 °C for 30±3min. Transforming interval: Max. 20 sec. Tested cycle: 100 cycles. The chip shall be stabilized at normal condition for 1~2 hours before measuring. 			

5.4.9	No mechanical damage.	① Temperature: -55±2°C
Resistance to	2 Impedance change: within ±20%.	② Duration: 1000 ⁺²⁴ hours.
Low	impodance change. Within 22076.	 The chip shall be stabilized at normal condition for 1~2 hours
Temperature		before measuring.
5.4.10 Resistance to High Temperature 5.4.11 Damp Heat	 No visible mechanical damage. Impedance change: within ±20%. No visible mechanical damage. Impedance change: within ±20%. 	 Temperature: 125±2°C Duration: 1000⁺²⁴ hours. The chip shall be stabilized at normal condition for 1~2 hours before measuring. Temperature: 60±2°C. Humidity: 90% to 95% RH.
(Steady States)		 3 Duration: 1000⁺²⁴ hours. 4 The chip shall be stabilized at normal condition for 1~2 hours before measuring.
5.4.12 Loading Under Damp Heat	 No visible mechanical damage. Impedance change: within ±20%. 	 Temperature: 60±2°C. Humidity: 90% to 95% RH. Duration: 1000⁺²⁴ hours. Applied current: Rated current. The chip shall be stabilized at normal condition for 1~2 hours before measuring.
5.4.13 Loading at High Temperature (Life Test)	No visible mechanical damage. Impedance change: within ±20%.	 Temperature: 125±2°C Duration: 1000⁺²⁴ hours. Applied current: Rated current. The chip shall be stabilized at normal condition for 1~2hours before measuring.

6. Packaging and Storage

6.1 Packaging

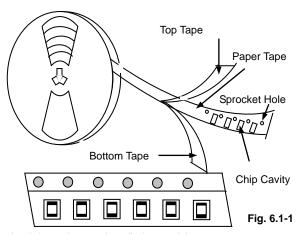
Tape Carrier Packaging:

Packaging code: T

- a. Tape carrier packaging are specified in attached figure Fig.6.1-1~3
- b. Tape carrier packaging quantity please see the following table:

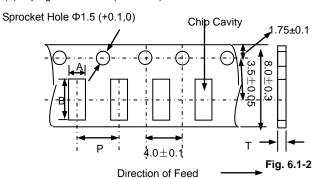
Туре	1005[0402]	1608[0603]	
T(mm)	0.5±0.15	0.8±0.15	
Tape	Paper Tape	Paper Tape	
Quantity	10K	4K	

(1) Taping Drawings (Unit: mm)



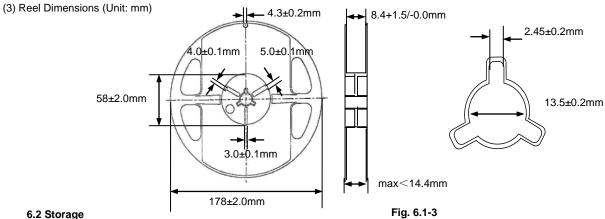
Remark: The sprocket holes are to the right as the tape is pulled toward the user

(2) Taping Dimensions (Unit: mm)



Paper Tape

Туре	А	В	Р	T max
1005[0402]	0.65±0.1	1.15±0.1	2.0±0.05	0.8
1608[0603]	1.0±0.2	1.8±0.2	4.0±0.1	1.1



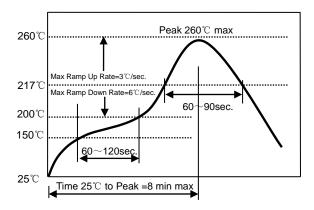
- The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to high humidity. Package must be stored at 40°C or less and 70% RH or less.
- The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to dust of harmful gas (e.g. HCl, sulfurous gas of H₂S).
- Packaging material may be deformed if package are stored where they are exposed to heat of direct sunlight.
- Minimum packages, such as polyvinyl heat-seal packages shall not be opened until they are used. If opened, use the reels as soon as
- Solderability specified in Clause 5.4.6 shall be guaranteed for 12 months from the date of delivery on condition that they are stored at the environment specified in Clause 3 . For those parts, which passed more than 12 months shall be checked solder-ability before use.

Recommended Soldering Technologies

7.1 Re-flowing Profile:

- Δ Preheat condition: 150 ~200 °C/60~120sec.
- Δ Allowed time above 217C: 60~90sec.
- \triangle Max temp: 260°C
- Δ Max time at max temp: 10sec. \triangle Solder paste: Sn/3.0Ag/0.5Cu Allowed Reflow time: 2x max

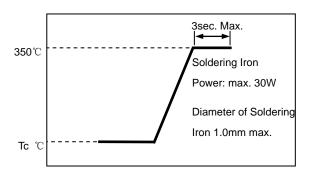
[Note: The reflow profile in the above table is only for qualification and is not meant to specify board assembly profiles. Actual board assembly profiles must be based on the customer's specific board design, solder paste and process, and should not exceed the parameters as the Reflow profile shows.]



7.2 Iron Soldering Profile.

- △ Iron soldering power: Max.30W
- Pre-heating: 150 °C/60 sec. Λ
- Δ Soldering Tip temperature: 350 ℃ Max.
- Soldering time: 3sec Max.
- \triangle Solder paste: Sn/3.0Ag/0.5Cu
- Max.1 times for iron soldering

[Note: Take care not to apply the tip of the soldering iron to the terminal electrodes.]



Appendix A: Electrical Characteristics

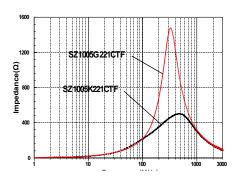
I SZ1005-C Series

Part Number	Impedance (Ω)	Z Test Freq. (MHz)	DCR (Ω) Max.	Ir (mA) Max.	Thickness (mm)[inch]
SZ1005G050CTF	0~15	100	0.08	500	
SZ1005G221CTF	220±25%	100	0.60	250	
SZ1005K750CTF	75±25%	100	0.20	600	
SZ1005K121CTF	120±25%	100	0.30	400	
SZ1005K221CTF	220±25%	100	0.40	300	0.5.0.45
SZ1005K301CTF	300±25%	100	0.55	300	0.5±0.15
SZ1005K471CTF	470±25%	100	0.60	200	[0.020±0.006]
SZ1005K601CTF	600±25%	100	0.65	200	
SZ1005K102CTF	1000±25%	100	0.90	200	
SZ1005K152CTF	1500±25%	100	1.20	100	
SZ1005K182CTF	1800±25%	100	1.40	100	

II . SZ1608-C Series

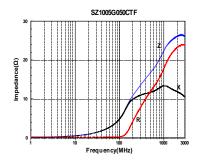
1 . 32 1000-C Series					
Part Number	Impedance (Ω)	Z Test Freq. (MHz)	DCR (Ω) Max.	Ir (mA) Max.	Thickness (mm)[inch]
SZ1608G600CTF	60±25%	100	0.25	800	
SZ1608G121CTF	120±25%	100	0.30	700	
SZ1608G221CTF	220±25%	100	0.45	600	
SZ1608G331CTF	330±25%	100	0.58	550	
SZ1608K601CTF	600±25%	100	0.60	300	0.8±0.15
SZ1608K102CTF	1000±25%	100	0.70	250	[.031±.006]
SZ1608K152CTF	1500±25%	100	0.75	250	
SZ1608K182CTF	1800±25%	100	0.85	200	
SZ1608K222CTF	2200±25%	100	0.90	200	
SZ1608K252CTF	2500±25%	100	1.00	200	

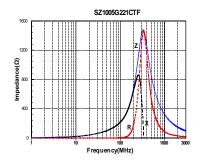
G, K Material Comparison

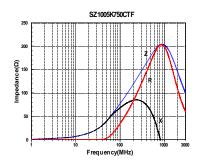


Impedance Frequency Characteristic

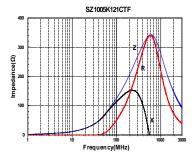
SZ1005-C Series

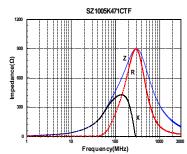


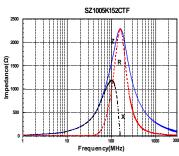




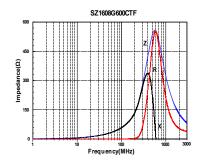
SZ1005-C Series

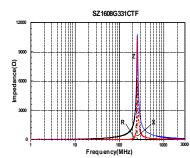


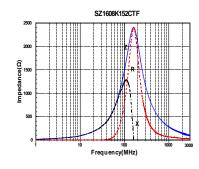


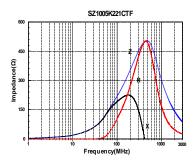


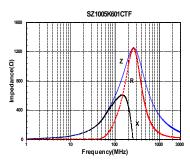
SZ1608-C Series

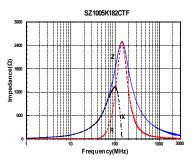


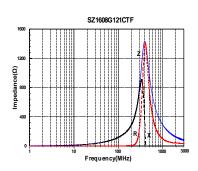


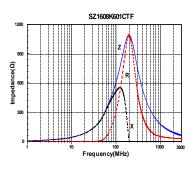


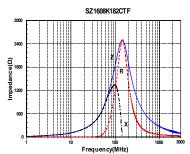


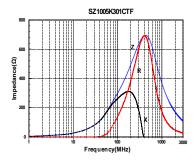


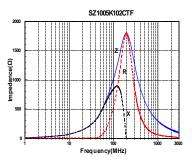


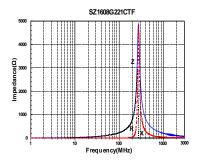


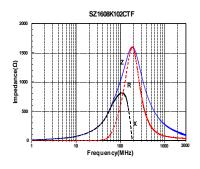


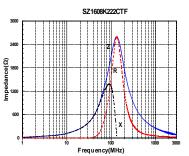












SZ1608-C Series

